

## Notice of References Cited

Application/Control No.

Applicant(s)/Patent Under Reexamination HASEGAWA, TAKASHI

Examiner

Justin P. Bettendorf

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**U.S. PATENT DOCUMENTS** 

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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## FOREIGN PATENT DOCUMENTS

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	N	EP 0903801 A2	03-1999	Japan	Okada et al.	H01P 1/387
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## **NON-PATENT DOCUMENTS**

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